Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/691,539	OBA ET AL.
Examiner	Art Unit
Hai C. Pham	2861

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	236-237, 246-247	6/17/2005	НР

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST		4/28/2005	НР
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